Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	nder	
10/722,178	MASON, JAMES STEPHEN		
Examiner	Art Unit	_	
Hai L. Nguyen	2816		

	SEARCHED				
Class	Subclass	Date	Examiner		
331	16,17	4/18/2005	HLN		
327	311,312				
327	551-559				
Update	Search	9/30/2005	HLN		
Update	Search	1/10/2006	HLN		

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Class	Subclass	Date	Examiner
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